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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10517917 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>MARTENS ET AL. |
|  | <b>Examiner</b><br><br>Heyi, Henok G           | <b>Art Unit</b><br><br>2609  |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |            |            |
|---|------------|------------|
| Search Notes  | Date       | Examiner   |
| Searched three different classes by combining with text search. I also used the international search report to reject all claims. | 07/12/07   | Henok Heyi |
| 369/94, 275.4, 288 (text search only - see the search history printout)   | 07/12/07   | Henok Heyi |
| Updated search and consulted with Primary Wayne Young.  | 07/03/2008 | Henok Heyi |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |